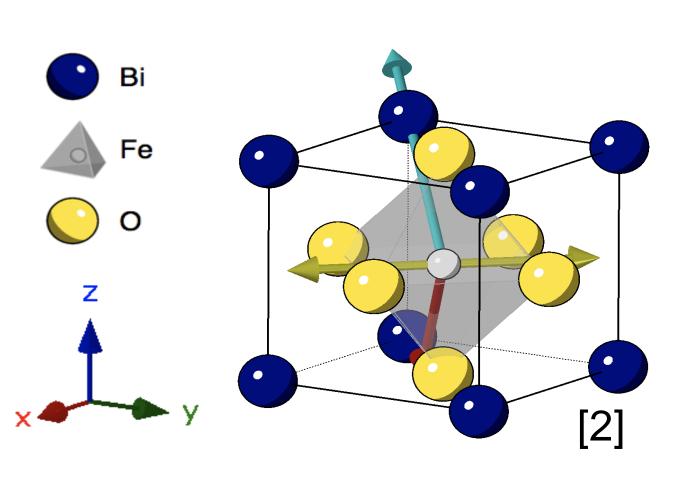




Introduction

Spintronics

• Are low-power, quantum-mechanical devices that utilize magnetism to store information. [1]

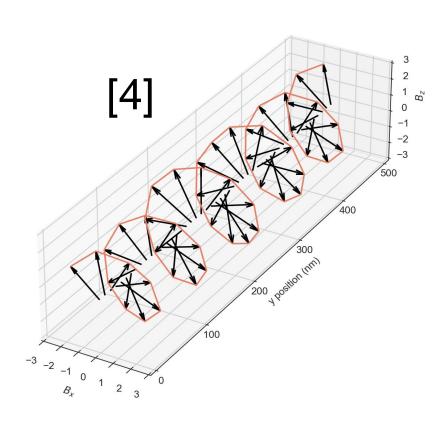


BiFeO₃ (BFO)

- Has a perovskite crystal structure.
- Is a room temperature ferroelectric and antiferromagnet.
- Has high polarization along the bodycentered diagonal. [1]

Single-Domain Structure

- Has only one variation of the ferroelectric polarization direction.
- Has no ferroelectric domain walls. [3]



Spin Cycloids

- Are created in BFO ferroelectric domains by the Dzyaloshinskii-Moriya interaction of coupled polarization and spin [1].
- Act as highways for spin travel but are interrupted by ferroelectric domain walls [4].

(yellow)

(blue)

Objective: The epitaxial growth of (110) BFO that is single-domain to harness the spin cycloid for spintronics.

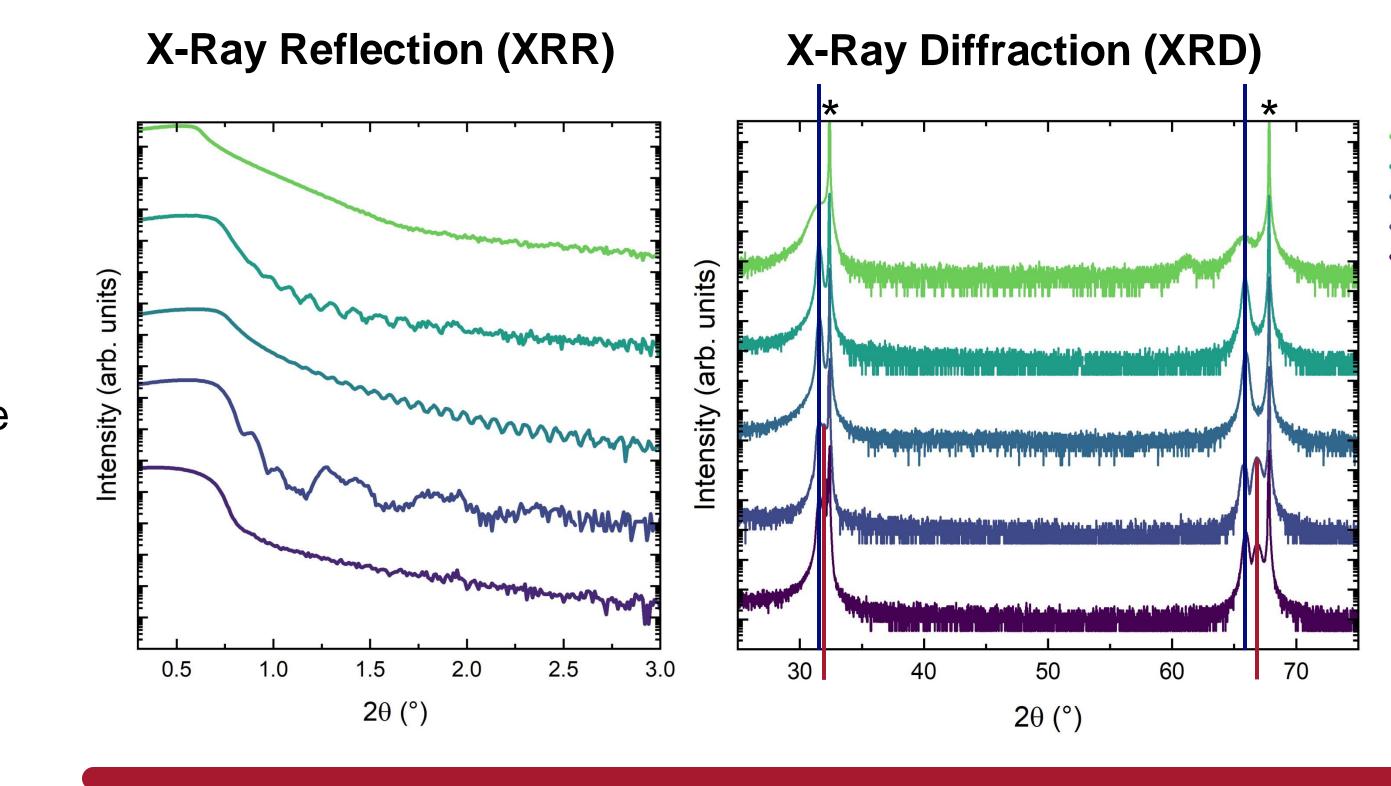
Growth Methods

- BFO (110) BFO (110) Sample structure: 30nm SRO (110) • $SrTiO_3$ (STO) or STO (110) • $SrRuO_3$ (SRO) STO (110) Substrate Substrate Ultrahigh Vacuum Chamber **Molecular-Beam Epitaxy** • Elemental sources are Resistive heated to create cation heating Substrate beams that oxidize on the (red) (black) substrate in a distilled ozone environment. **BiFeO₃ Growth Parameters** Distilled ozone • 80% O_3 and 20% O_2 • 5 x 10⁻⁶ Torr • 8:1 Bi:Fe flux ratio Bismuth source Iron source Substrate temperature
 - 675°C

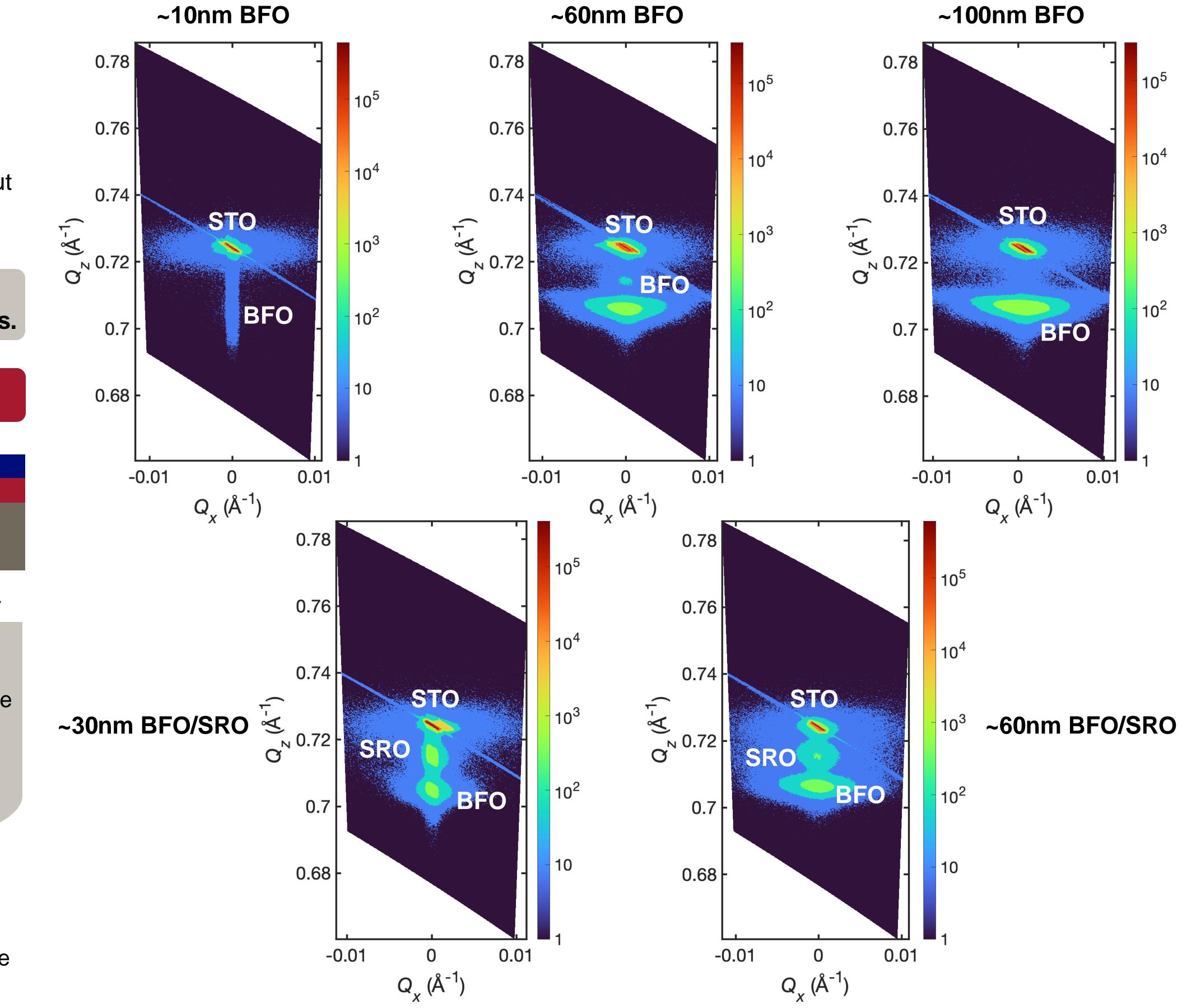
Epitaxial Growth of Single-Domain (110) $BiFeO_3$ Thin Films

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Characterization Methods



Reciprocal Space Map (RSM) at the 221 peak





10 nm BFO **—** 30 nm BFO — 100 nm BFO - 30 nm BFO/SRO 60 nm BFO/SRO ★ STO 110 substrate peaks BFO 110 film peaks SRO 110 film peaks

XRR

 Confirms film thickness.

XRD

- Confirms film phase purity.
- Confirms film and substrate orientation.

Sample Quality

RSM Results

- [3].

Confirm single-domain structure with

- (PFM) to observe
- Nitrogen Vacancy cycloids.

I would like to acknowledge my mentor Maya Ramesh and principal investigator Dr. Darrell G. Schlom for their support and guidance in this project. This research is funded by the National Science Foundation (NSF) Platform for the Accelerated Realization, Analysis, and Discovery of Interface Materials (PARADIM) and the NSF Research Experience for Undergraduates Site: Summer Research Program at PARADIM.



Results

Consistently correct XRR and XRD peaks indicate quality, stoichiometric BFO (110) film growth.

• The BFO 221 peak is characteristic of structural variations, including ferroelectric domain structure variations in the film

• Splitting of the BFO 221 peak in the ~60nm BFO sample indicates multiple ferroelectric domains. • The single BFO 221 peak in the ~100nm BFO, ~30nm BFO/SRO, and ~60nm BFO/SRO samples indicates successful single-domain structure. The indistinguishable ~10nm BFO 221 peak requires further testing.

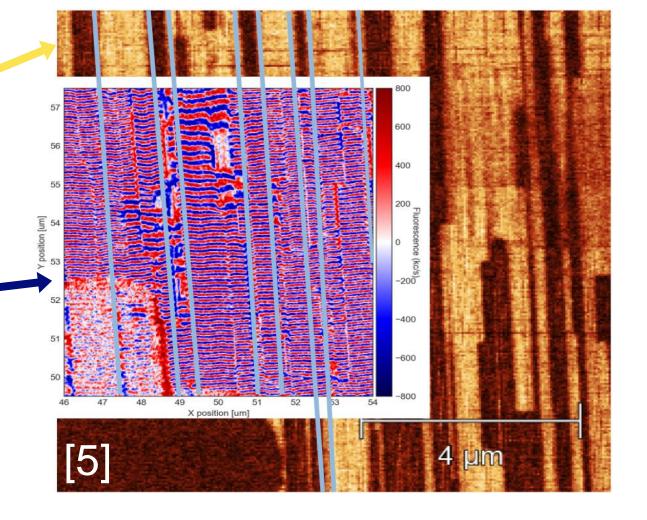
Conclusion: Most epitaxial (110) BFO growths were likely single-domain.

Future Work

 Piezoforce Microscopy ferroelectric domains.

Magnetometry to observe

magnetic domains and spin



Acknowledgements

References

[1] D. Sando, et al., *J. Phys.: Condens. Matter* **26**, (2014), 473201. [2] A. Fert, et al., *Rev. Mod. Phys.* **96**, (2024). [3] Y. Chu, et al., Adv. Mater. 19, (2007), 2662-2666. [4] A. Haykal, et al., *Nat. Commun.* **11**, (2020), 1704. [5] P. Meisenheimer, et al., Adv. Mater., (2024), 2404639.